FDME905PT

P-Channel POWERTRENCH® MOSFET

−12 V, −8 A, 22 mΩ

ON Semiconductor®

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V_{DS}	I_D MAX	$R_{DS(on)}$ MAX
−12 V	−8 A	22 mΩ

General Description

This device is designed specifically for battery charging or load switching in cellular handset and other ultraportable applications. It features a MOSFET with low on−state resistance.

The MicroFET 1.6x1.6 Thin package offers exceptional thermal performance for its physical size and is well suited to switching and linear mode applications.

Features

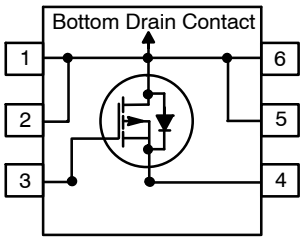
- Max $R_{DS(on)}$ = 22 mΩ at V_{GS} = −4.5 V, I_D = −8 A
- Max $R_{DS(on)}$ = 26 mΩ at V_{GS} = −2.5 V, I_D = −7.3 A
- Max $R_{DS(on)}$ = 97 mΩ at V_{GS} = −1.8 V, I_D = −3.8 A
- Low Profile: 0.55 mm Maximum in the New Package MicroFET 1.6x1.6 Thin
- Free from Halogenated Compounds and Antimony Oxides
- These Devices are Pb−Free and are RoHS Compliant

MOSFET MAXIMUM RATINGS (T_A = 25°C, Unless otherwise specified)

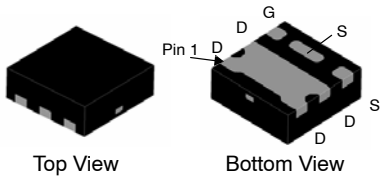
Symbol	Parameter	Ratings	Unit
V_{DS}	Drain to Source Voltage	−12	V
V_{GS}	Gate to Source Voltage	±8	V
I_D	Drain Current Continuous (T_A = 25°C) (Note 1a) Pulsed	 −8 −30	A
P_D	Power Dissipation (T_A = 25°C) (Note 1a) (T_A = 25°C) (Note 1b)	 2.1 0.7	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	−55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

ELECTRICAL CONNECTION



P-Channel MOSFET



Top View Bottom View

MicroFET
(UDFN6)
CASE 517DV

MARKING DIAGRAM



&Z	= Assembly Plant Code
&2	= Numeric Date Code
&K	= Lot Code
E95	= Specific Device Code

ORDERING INFORMATION

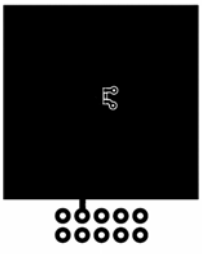
See detailed ordering and shipping information on page 2 of this data sheet.

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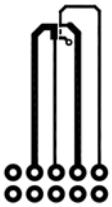
THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	4.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	60	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	175	°C/W

1. Repetitive rating: pulse−width limited by maximum junction temperature.



a) 60 °C/W when mounted on a 1 in^2 pad of 2 oz copper



b). 175 °C/W when mounted on a minimum pad of 2 oz copper

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
E95	FDME905PT	MicroFET 1.6x1.6 Thin (Pb−Free / Halide Free)	7″	8 mm	5,000 Units

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 250 μA, V_{GS} = 0 V	−12	−	−	V
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C	−	−8.7	−	mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = −9.6 V, V_{GS} = 0 V	−	−	−1	μA
I_{GSS}	Gate to Source Leakage Current, Forward	V_{GS} = ±8 V, V_{DS}= 0 V	−	−	±100	nA
ON CHARACTERISTICS						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = −250 μA	−0.4	−0.7	−1.0	V
$\Delta V_{GS(th)}/\Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C	−	2.5	−	mV/°C

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
ON CHARACTERISTICS						
$R_{DS(on)}$	Drain to Source On Resistance	V_{GS} = −4.5 V, I_D = −8 A V_{GS} = −2.5 V, I_D = −7.3 A V_{GS} = −1.8 V, I_D = −3.8 A, V_{GS} = −4.5 V, I_D = −8 A, T_J = 125°C	– – – 	18 22 28 23	22 26 97 32	mΩ
g_{FS}	Forward Transconductance	V_{DS} = −5 V, I_D = −8 A	–	38	–	S
DYNAMIC CHARACTERISTICS						
C_{iss}	Input Capacitance	V_{DS} = −6 V, V_{GS} = 0 V, f = 1 MHZ	–	1740	2315	pF
C_{oss}	Output Capacitance		–	350	525	pF
C_{rss}	Reverse Transfer Capacitance		–	311	465	pF
SWITCHING CHARACTERISTICS						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = −6 V, I_D = −8 A, V_{GS} = −4.5 V, R_{GEN} = 6 Ω	–	9.5	19	ns
t_r	Rise Time		–	8	16	ns
$t_{d(off)}$	Turn-Off Delay Time		–	90	144	ns
t_f	Fall Time		–	42	67	ns
Q_g	Total Gate Charge	V_{DD} = −6 V, I_D = −8 A V_{GS} = −4.5 V	–	14	20	nC
Q_{gs}	Gate to Source Gate Charge		–	2.4	–	nC
Q_{gd}	Gate to Drain “Miller” Charge		–	3	–	nC
DRAIN-SOURCE DIODE CHARACTERISTICS						
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = −8 A (Note 2)	–	−0.8	−1.2	V
		V_{GS} = 0 V, I_S = −1.8 A (Note 2)	–	−0.7	−1.2	V
t_{rr}	Reverse Recovery Time	I_F = −8 A, di/dt = 100 A/μs	–	17	31	ns
Q_{rr}	Reverse Recovery Charge		–	4.5	10	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)

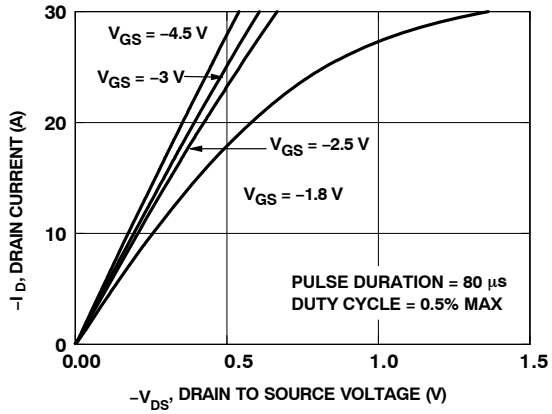


Figure 1. On-Region Characteristics

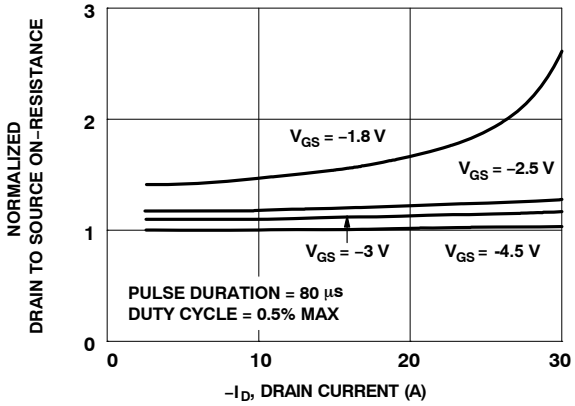


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

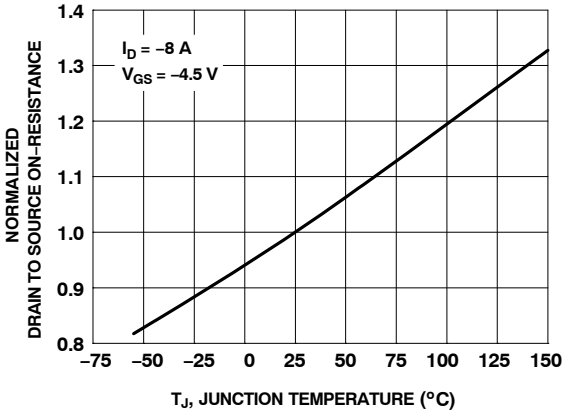


Figure 3. Normalized On-Resistance vs. Junction Temperature

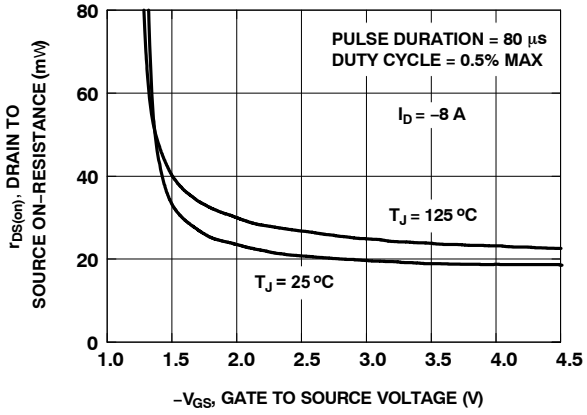


Figure 4. On-Resistance vs. Gate to Source Voltage

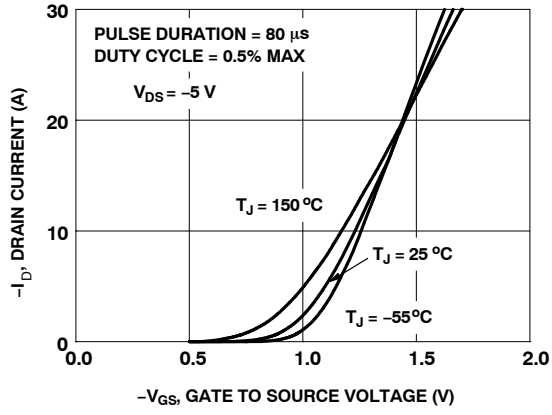


Figure 5. Transfer Characteristics

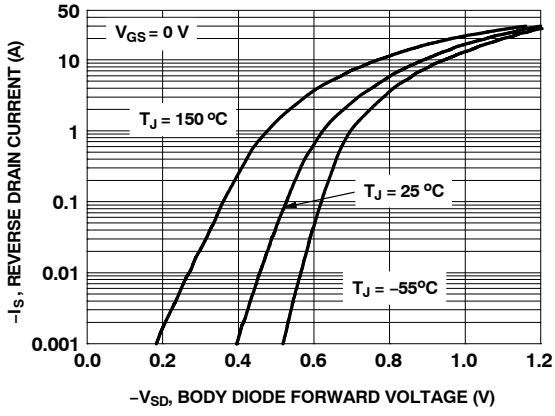


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)

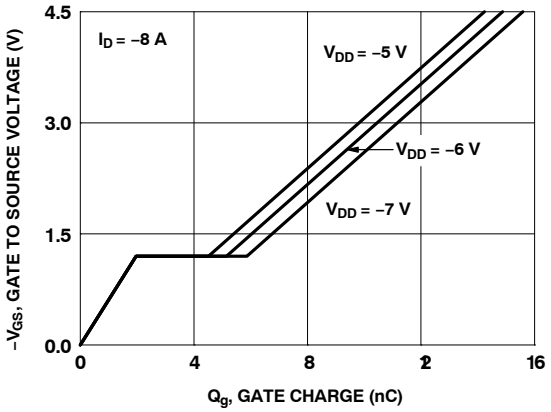


Figure 7. Gate Charge Characteristics

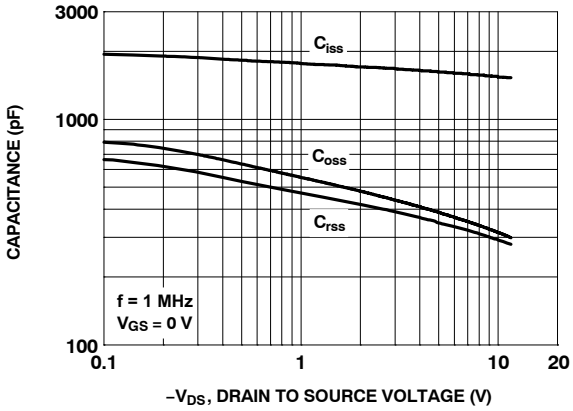


Figure 8. Capacitance vs. Drain to Source Voltage

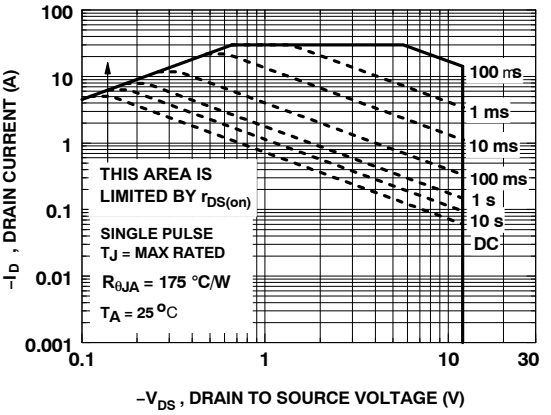


Figure 9. Forward Bias Safe Operating Area

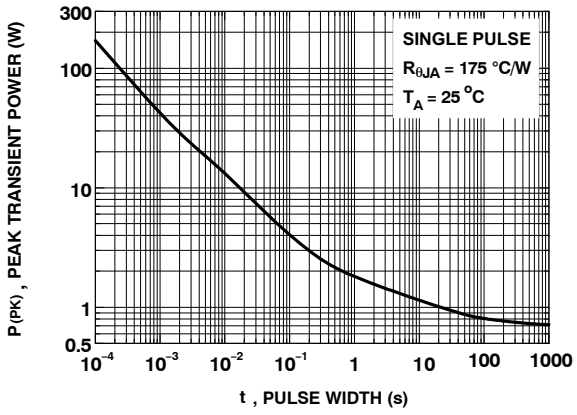


Figure 10. Single Pulse Maximum Power Dissipation

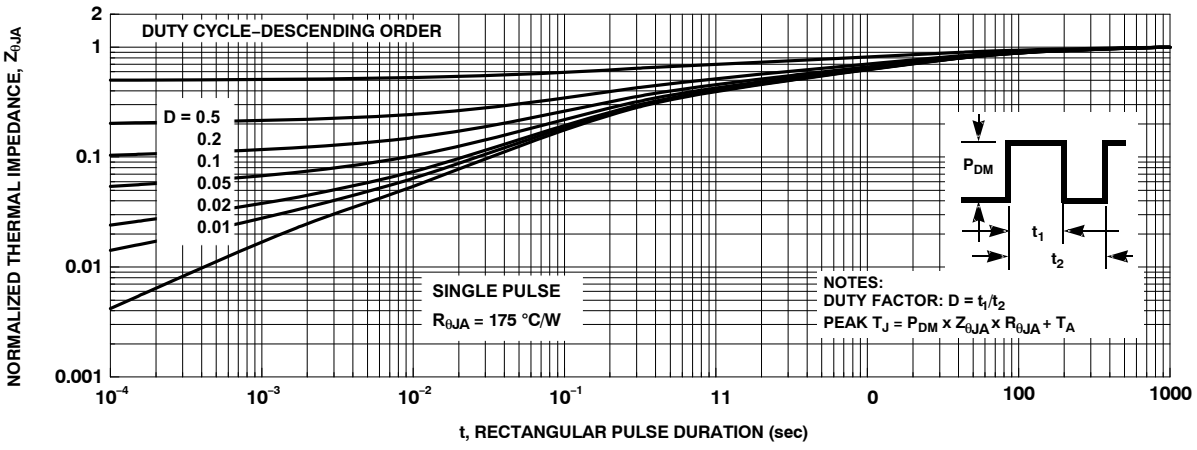
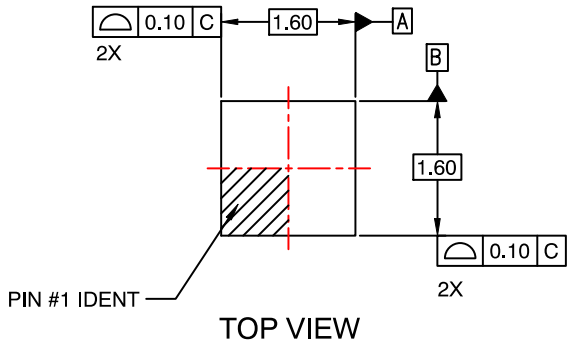


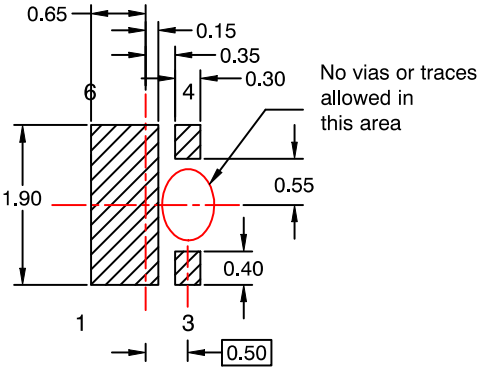
Figure 11. Junction-to-Ambient Transient Thermal Response Curve

PACKAGE DIMENSIONS

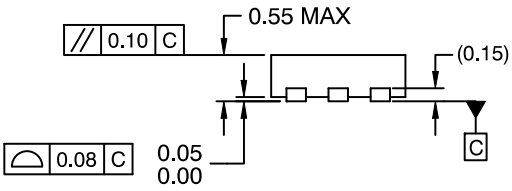
UDFN6 1.6x1.6, 0.5P
CASE 517DV
ISSUE O



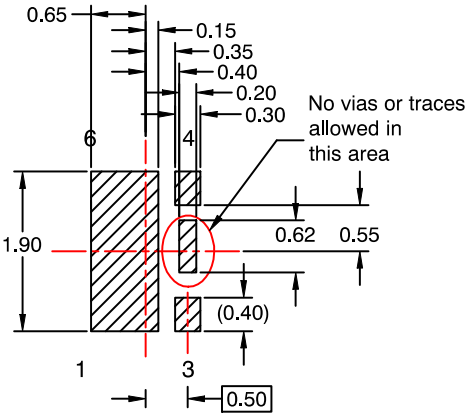
TOP VIEW



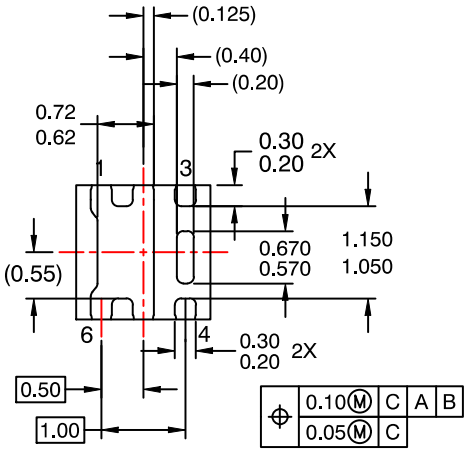
RECOMMENDED LAND PATTERN OPT 1



SIDE VIEW



RECOMMENDED LAND PATTERN OPT 2



BOTTOM VIEW

NOTES:
A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION
B. DIMENSIONS ARE IN MILLIMETERS.
C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.

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